

<b>Notice of References Cited</b>	Application/Control No. 10/001,389	Applicant(s)/Patent Under Reexamination WIKE ET AL.	
	Examiner Uyen-Chau N. Le	Art Unit 2876	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,341,125 A	08-1994	Plonsky et al.	340/572.3
*	B	US-6,154,135 A	11-2000	Kane et al.	340/572.3
*	C	US-6,155,486 A	12-2000	Lutz, Dusty L.	235/383
*	D	US-6,169,483 B1	01-2001	Ghaffari et al.	340/572.3
*	E	US-6,333,692 B1	12-2001	Andersen et al.	340/572.1
*	F	US-6,788,205 B1	09-2004	Mason et al.	340/572.3
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.